

General Description

- Latest advanced trench technology
- Low $R_{DS(ON)}$
- High Current Capability
- RoHS and Halogen-Free Compliant

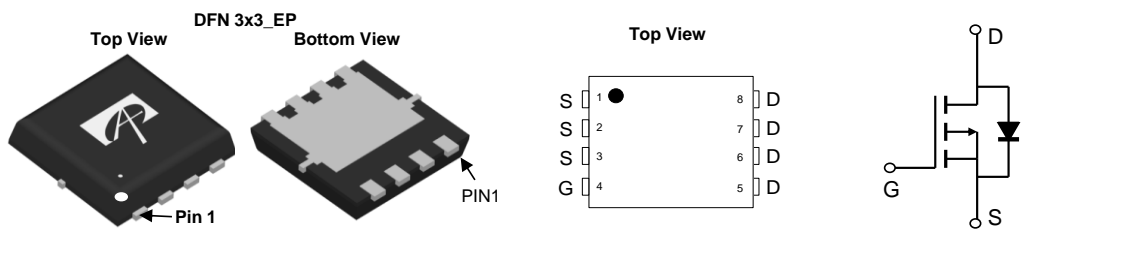
Applications

- Notebook AC-in load switch
- Battery protection charge/discharge

Product Summary

| | |
|-----------------------------------|------------------|
| V_{DS} | -30V |
| I_D (at $V_{GS}=-10V$) | -34A |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$) | < 7.8m Ω |
| $R_{DS(ON)}$ (at $V_{GS}=-4.5V$) | < 12.3m Ω |

100% UIS Tested
 100% Rg Tested



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AONR21357 | DFN 3x3 EP | Tape & Reel | 5000 |

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 25 | V |
| Continuous Drain Current ^G | I_D | $T_C=25^\circ\text{C}$ | -34 |
| | | $T_C=100^\circ\text{C}$ | -32.5 |
| Pulsed Drain Current ^C | I_{DM} | -136 | A |
| Continuous Drain Current | I_{DSM} | $T_A=25^\circ\text{C}$ | -21 |
| | | $T_A=70^\circ\text{C}$ | -17 |
| Avalanche Current ^C | I_{AS} | 39 | A |
| Avalanche energy $L=0.1\text{mH}$ ^C | E_{AS} | 76 | mJ |
| Power Dissipation ^B | P_D | $T_C=25^\circ\text{C}$ | 30 |
| | | $T_C=100^\circ\text{C}$ | 12 |
| Power Dissipation ^A | P_{DSM} | $T_A=25^\circ\text{C}$ | 5 |
| | | $T_A=70^\circ\text{C}$ | 3.2 |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|--------------|-----|---------------------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 20 | 25 | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient ^{A,D} | | Steady-State | 45 | 55 |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 3.5 | 4.2 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|--|---|------|------|-----------|---------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=-250\mu\text{A}$, $V_{GS}=0\text{V}$ | -30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | -1 -5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}$, $V_{GS}=\pm 25\text{V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$ | -1.3 | -1.7 | -2.3 | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}$, $I_D=-20\text{A}$ $T_J=125^\circ\text{C}$ | | 6.3 | 7.8 | m Ω |
| | | $V_{GS}=-4.5\text{V}$, $I_D=-16\text{A}$ | | 8.6 | 10.7 | |
| g_{FS} | Forward Transconductance | $V_{DS}=-5\text{V}$, $I_D=-20\text{A}$ | | 50 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}$, $V_{GS}=0\text{V}$ | | -0.7 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current ^G | | | | -34 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}$, $V_{DS}=-15\text{V}$, $f=1\text{MHz}$ | | 2830 | | pF |
| C_{oss} | Output Capacitance | | | 430 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 365 | | pF |
| R_g | Gate resistance | $f=1\text{MHz}$ | | 14 | 28 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $I_D=-20\text{A}$ | | 50 | 70 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 25 | 35 | nC |
| Q_{gs} | Gate Source Charge | | | 9 | | nC |
| Q_{gd} | Gate Drain Charge | | | 12 | | nC |
| $t_{D(on)}$ | Turn-On DelayTime | $V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $R_L=0.75\Omega$, $R_{GEN}=3\Omega$ | | 12.5 | | ns |
| t_r | Turn-On Rise Time | | | 18 | | ns |
| $t_{D(off)}$ | Turn-Off DelayTime | | | 125 | | ns |
| t_f | Turn-Off Fall Time | | | 66 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-20\text{A}$, $di/dt=500\text{A}/\mu\text{s}$ | | 62 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-20\text{A}$, $di/dt=500\text{A}/\mu\text{s}$ | | 32 | | nC |

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{\theta JA} \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}=150^\circ\text{C}$.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

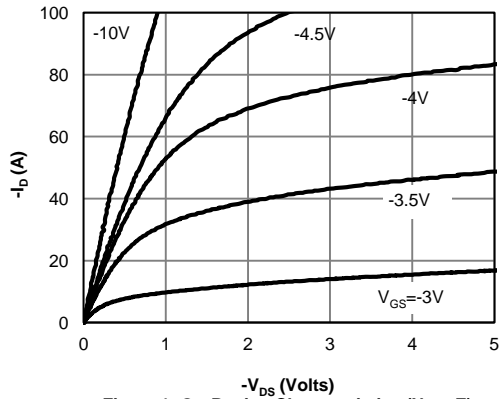


Figure 1: On-Region Characteristics (Note E)

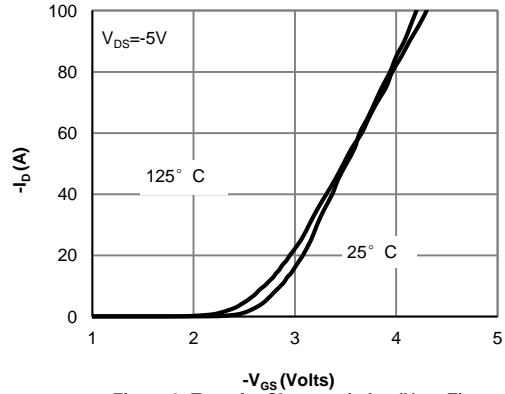


Figure 2: Transfer Characteristics (Note E)

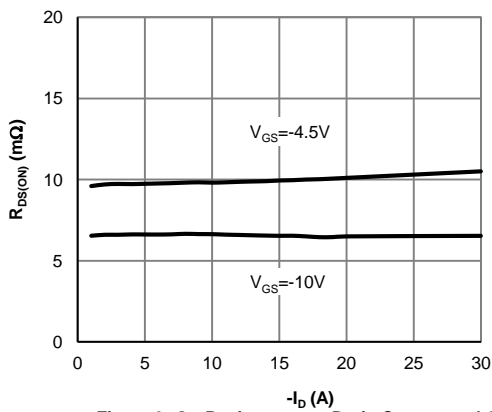


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

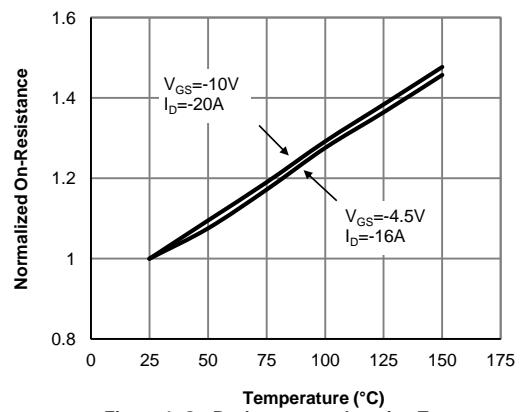


Figure 4: On-Resistance vs. Junction Temperature (Note E)

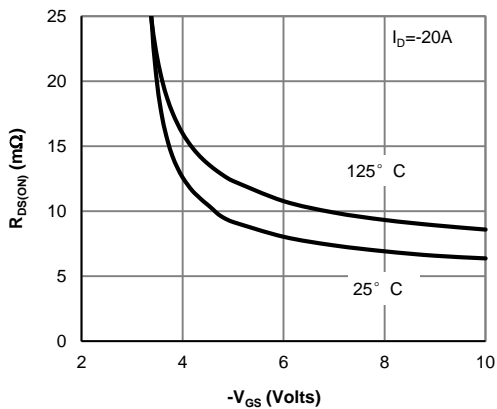


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

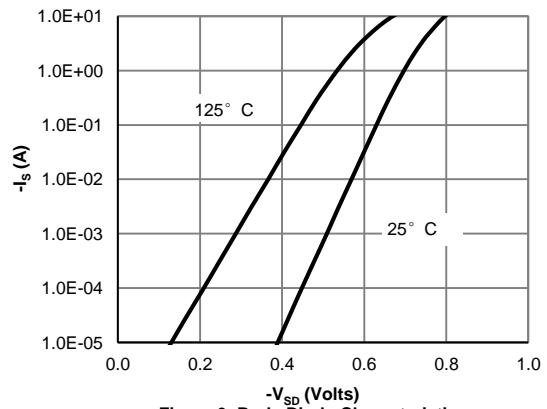


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

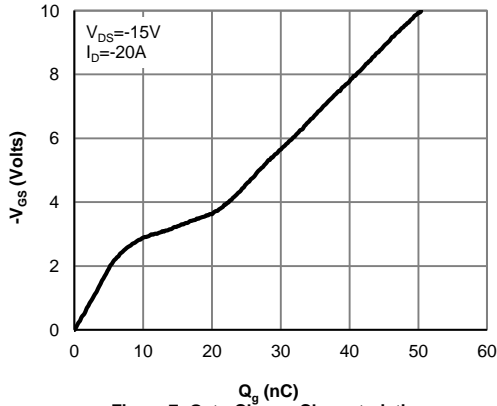


Figure 7: Gate-Charge Characteristics

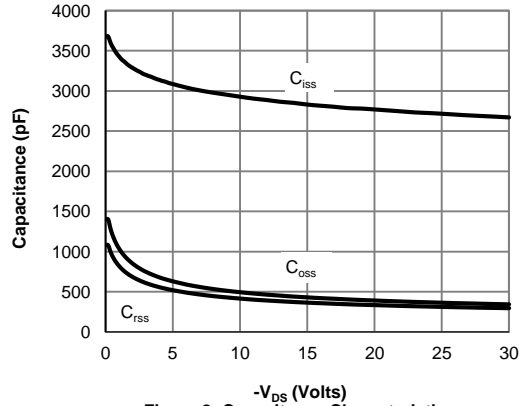


Figure 8: Capacitance Characteristics

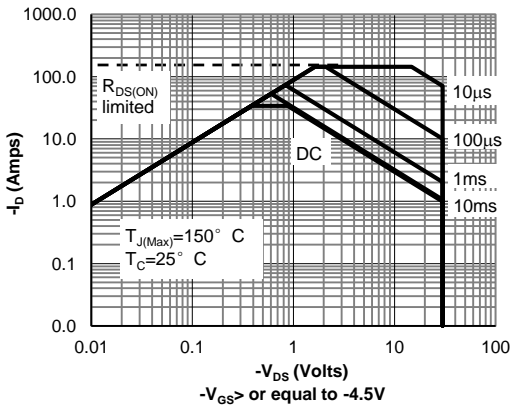


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

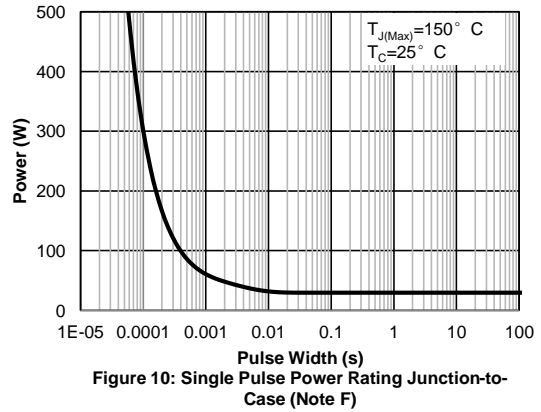


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

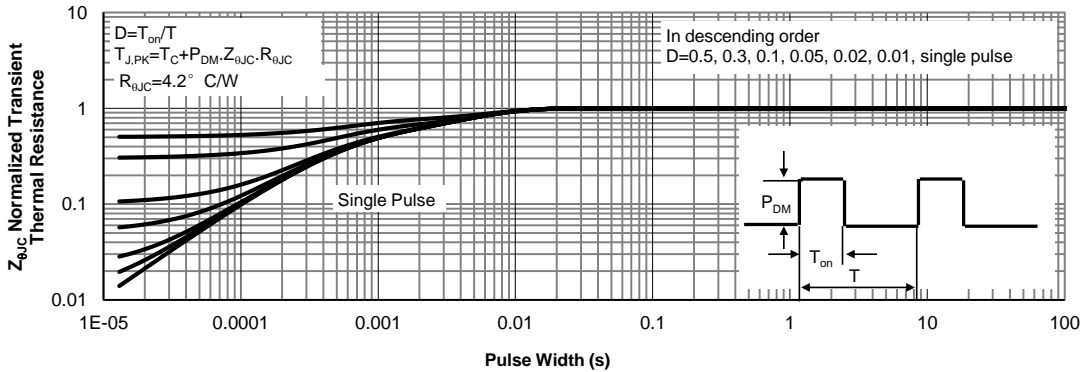


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

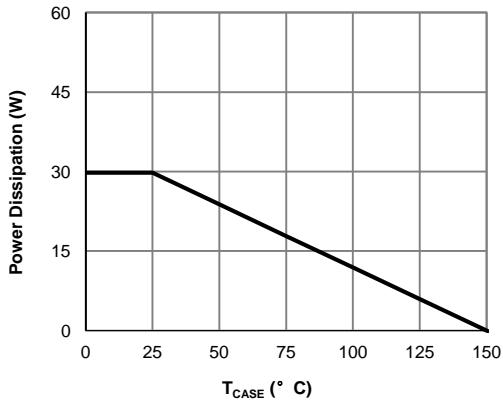


Figure 12: Power De-rating (Note F)

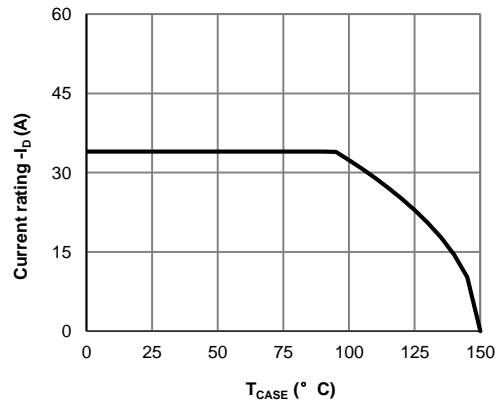


Figure 13: Current De-rating (Note F)

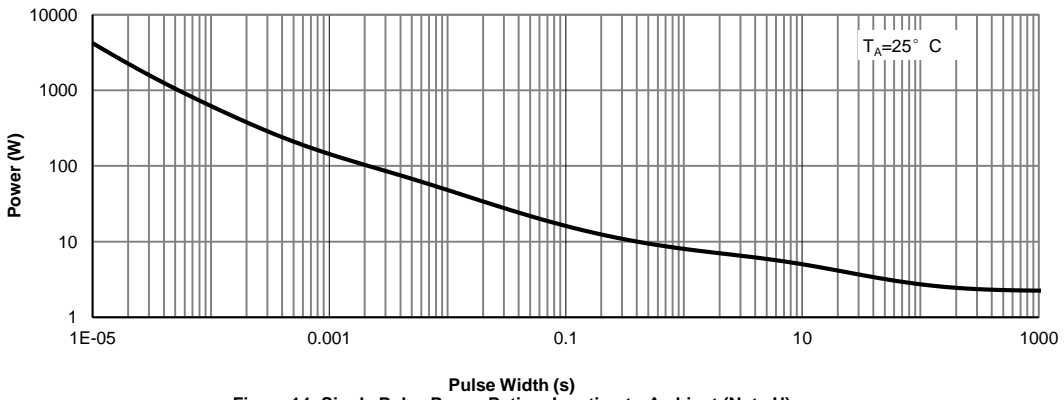


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

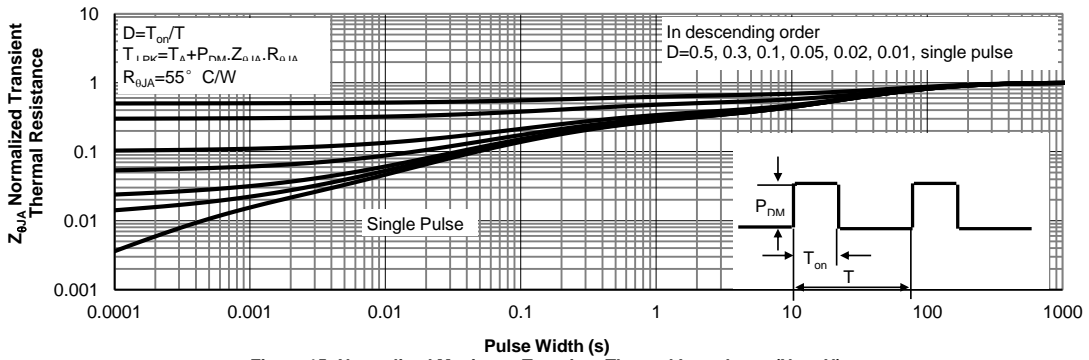
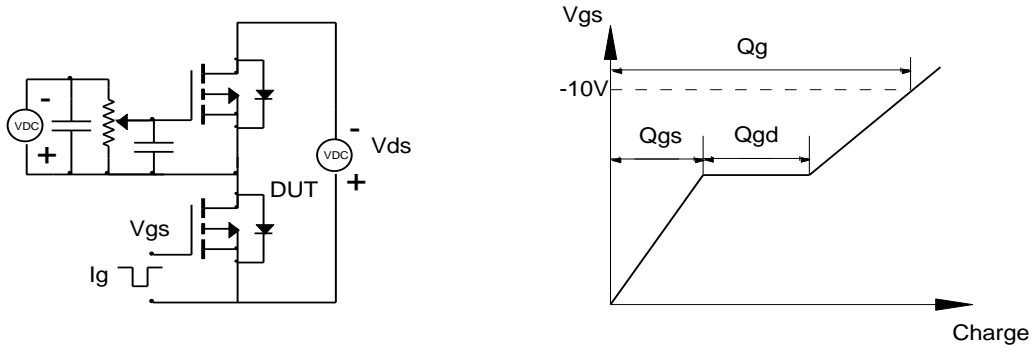
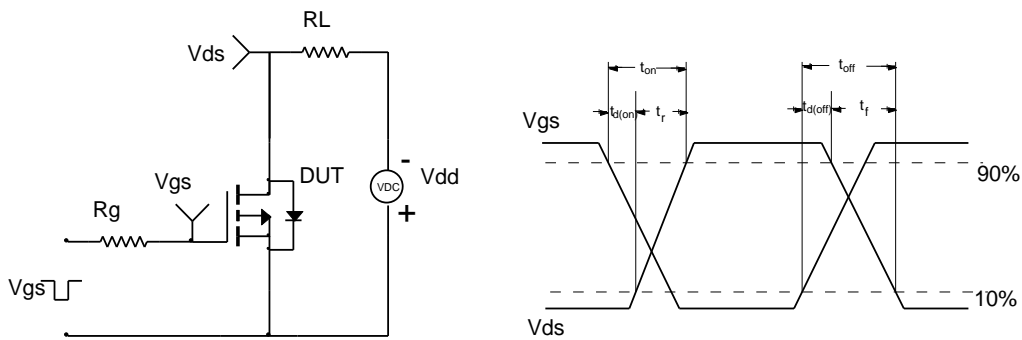


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

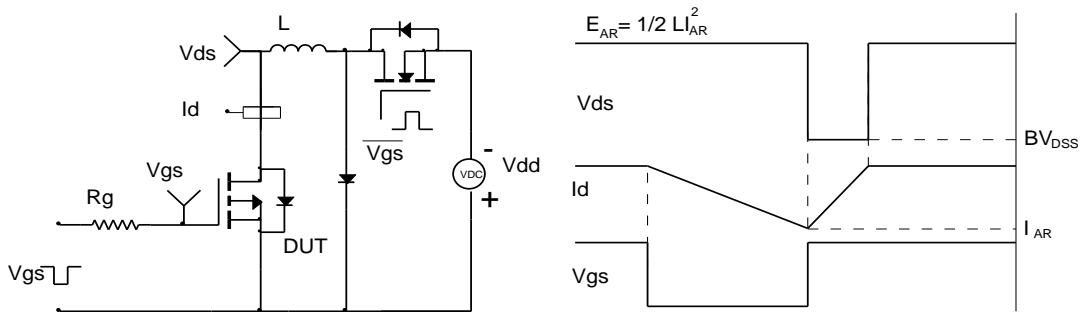
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

